

<b>Notice of References Cited</b>	Application/Control No. 10/589,836		Applicant(s)/Patent Under Reexamination HEIKO	
	Examiner Renee S. Luebke		Art Unit 2833	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,631,454	05-1997	Hubacher et al.	200/296
*	B	US-5,541,379	07-1996	Kim	200/321
*	C	US-7,080,889	07-2006	Ling et al.	200/50.02
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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